ON Semiconductor

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IGBT – Field Stop, Trench 650 V, 50 A

FGH4L50T65SQD

Description

Using novel field stop IGBT technology, ON Semiconductor's new series of field stop 4th generation IGBTs offer the optimum performance for solar inverter, UPS, welder, telecom, ESS and PFC applications where low conduction and switching losses are essential.

Features

- Maximum Junction Temperature: $T_J = 175$ °C
- Positive Temperature Co-efficient for Easy Parallel Operating
- High Current Capability
- Low Saturation Voltage: $V_{CE(Sat)} = 1.6 \text{ V (Typ.)} @ I_C = 50 \text{ A}$
- 100% of the Parts are Tested for I_{I,M}
- High Input Impedance
- Fast Switching
- Tight Parameter Distribution
- This Device is Pb-Free and is RoHS Compliant

Applications

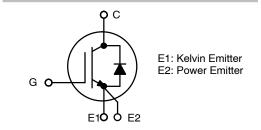
• Solar Inverter, UPS, Welder, Telecom, ESS, PFC



ON Semiconductor®

www.onsemi.com

V _{CES}	Ic
650 V	50 A





TO-247-4LD CASE 340CJ

MARKING DIAGRAM



\$Y = ON Semiconductor Logo &Z = Assembly Plant Code

&3 = Numeric Date Code &K = Lot Code

FGH4L50T65SQD = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping
FGH4L50T65SQD	TO-247-4LD	30 Units / Rail

ABSOLUTE MAXIMUM RATINGS

Symbol	Rating	Value	Unit
V _{CES}	Collector to Emitter Voltage	650	V
V _{GES}	Gate to Emitter Voltage	+20	V
	Transient Gate to Emitter Voltage	+30	V
I _C	Collector Current (Note 1) $T_C = 25^{\circ}C$ $T_C = 100^{\circ}C$	80 50	A
I _{LM}	Pulsed Collector Current (Note 2), T _C = 25°C	200	А
I _{CM}	Pulsed Collector Current (Note 3)	200	Α
l _F	Diode Forward Current (Note 1) $T_C = 25^{\circ}C$ $T_C = 100^{\circ}C$	40 30	А
IFM	Pulsed Diode Maximum Forward Current	200	Α
P _D	Maximum Power Dissipation $T_C = 25^{\circ}C$ $T_C = 100^{\circ}C$	268 134	W
TJ	Operating Junction Temperature	-55 to +175	°C
TSTG	Storage Temperature Range	-55 to +175	°C
T _L	Maximum Lead Temp. for Soldering Purposes, 1/8" from Case for 5 Seconds	265	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Value limited by bond wire.

- 2. V_{CC} = 400 V, V_{GE} = 15 V, I_{C} = 200 A, R_{G} = 15 Ω , Inductive Load. 3. Repetitive rating: Pulse width limited by max. junction temperature.

THERMAL CHARACTERISTICS

Symbol	Characteristics	Value	Unit
$R_{\theta JC}$ (IGBT)	Thermal Resistance, Junction to Case, Max.	0.56	°C/W
$R_{\theta JC}$ (Diode)	Thermal Resistance, Junction to Case, Max.	1.25	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient, Max.	40	°C/W

ELECTRICAL CHARACTERISTICS OF THE IGBT (T₁ = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit		
OFF CHARACTERISTICS								
BV _{CES}	Collector to Emitter Breakdown Voltage	$V_{GE} = 0 \text{ V}, I_C = 1 \text{ mA}$	650	-	-	V		
$\Delta BV_{CES}/\Delta T_{J}$	Temperature Coefficient of Breakdown Voltage	f Breakdown $V_{GE} = 0 \text{ V, I}_{C} = 1 \text{ mA}$		0.6	-	V/°C		
I _{CES}	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0 V$	-	-	250	μΑ		
I _{GES}	G-E Leakage Current	V _{GE} = V _{GES} , V _{CE} = 0 V	-	-	±400	nA		
ON CHARACT	ERISTICS							
V _{GE(th)}	G-E Threshold Voltage	I_C = 50 mA, V_{CE} = V_{GE}	2.6	4.5	6.4	V		
V _{CE(sat)}	V _{CE(sat)} Collector to Emitter Saturation Voltage I _C = 50 A, V _{GE} = 15		-	1.6	2.1	V		
		I _C = 50 A, V _{GE} = 15 V, T _J = 175°C	-	1.92	-	V		
DYNAMIC CHA	ARACTERISTICS							
C _{ies}	Input Capacitance	V _{CE} = 30 V, V _{GE} = 0 V, f = 1MHz	-	3070	-	pF		
C _{oes}	Output Capacitance	1	-	84	-	pF		
C _{res}	Reverse Transfer Capacitance	1	-	10	-	pF		

$\textbf{ELECTRICAL CHARACTERISTICS OF THE IGBT} \ (T_J = 25^{\circ}C \ unless \ otherwise \ noted) \ (continued)$

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
SWITCHING (CHARACTERISTICS, INDUCTIVE LOA	AD	<u>.</u>		ı	
T _{d(on)}	Turn-On Delay Time	V _{CC} = 400 V, I _C = 25 A,	-	22.40	_	ns
T _r	Rise Time	$R_G = 15 \Omega$, $V_{GE} = 15 V$, Inductive Load, $T_J = 25^{\circ}C$	-	11.20	-	ns
T _{d(off)}	Turn-Off Delay Time		_	162	_	ns
T _f	Fall Time		-	8	_	ns
E _{on}	Turn-On Switching Loss		-	0.28	_	mJ
E _{off}	Turn-Off Switching Loss		-	0.20	_	mJ
E _{ts}	Total Switching Loss		-	0.48	_	mJ
T _{d(on)}	Turn-On Delay Time	$V_{CC} = 400 \text{ V}, I_{C} = 50 \text{ A},$	-	24	_	ns
T _r	Rise Time	$R_G = 15 \Omega$, $V_{GE} = 15 V$, Inductive Load, $T_J = 25^{\circ}C$	-	20.80	_	ns
T _{d(off)}	Turn-Off Delay Time		-	158.40	_	ns
T _f	Fall Time		-	11.20	-	ns
E _{on}	Turn-On Switching Loss		-	0.66	-	mJ
E _{off}	Turn-Off Switching Loss		-	0.44	-	mJ
E _{ts}	Total Switching Loss		-	1.10	-	mJ
T _{d(on)}	Turn-On Delay Time	V _{CC} = 400 V, I _C = 25 A,	-	19.20	-	ns
T _r	Rise Time	R_G = 15 Ω, V_{GE} = 15 V, Inductive Load, T_J = 175°C	-	16	-	ns
T _{d(off)}	Turn-Off Delay Time		-	178	-	ns
T _f	Fall Time		-	6.40	-	ns
E _{on}	Turn-On Switching Loss		-	0.59	-	mJ
E _{off}	Turn-Off Switching Loss		-	0.32	-	mJ
E _{ts}	Total Switching Loss		-	0.91	-	mJ
T _{d(on)}	Turn-On Delay Time	$V_{CC} = 400 \text{ V}, I_{C} = 50 \text{ A},$	-	22.40	-	ns
T _r	Rise Time	R_G = 15 Ω, V_{GE} = 15 V, Inductive Load, T_J = 175°C	-	26.40	_	ns
T _{d(off)}	Turn-Off Delay Time		-	168	_	ns
T _f	Fall Time		-	11.20	_	ns
E _{on}	Turn-On Switching Loss		_	1.16	-	mJ
E _{off}	Turn-Off Switching Loss		_	0.68	-	mJ
E _{ts}	Total Switching Loss		-	1.84	-	mJ
Qg	Total Gate Charge	V _{CE} = 400 V, I _C = 50 A, V _{GE} = 15 V	-	92	_	nC
Q _{ge}	Gate to Emitter Charge	v _{GE} = 15 v	-	17	_	nC
Q _{gc}	Gate to Collector Charge		-	21	_	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

DIODE CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Diode Reverse Recovery Charge

Diode Reverse Recovery Current

Reverse Recovery Energy

Reverse Recovery Energy

Diode Reverse Recovery Time

Diode Reverse Recovery Charge

Diode Reverse Recovery Current

Diode Reverse Recovery Time

Diode Reverse Recovery Charge

Diode Reverse Recovery Current

 Q_{rr}

 I_{rr}

 E_{rec}

 T_{rr}

 \mathbf{Q}_{rr}

 I_{rr}

 E_{rec}

 T_{rr}

 Q_{rr}

 I_{rr}

Symbol	Parameter	Test Conditions		Min	Тур	Max	Unit
V _{FM}	Diode Forward Voltage	I _F = 30 A	T _J = 25°C	-	2.1	2.6	V
			T _J = 175°C	-	1.8	ı	
DIODE SWI	DIODE SWITCHING CHARACTERISTICS, INDUCTIVE LOAD						
E _{rec}	Reverse Recovery Energy	T _J = 25°C, V _{CE} = 400 V, I _F = 15 A, di _F /dt = 1000 A/μs		-	11	Ī	μJ
T _{rr}	Diode Reverse Recovery Time			ı	25	ı	ns
Q _{rr}	Diode Reverse Recovery Charge			-	175	-	nC
I _{rr}	Diode Reverse Recovery Current			-	14	-	Α
E _{rec}	Reverse Recovery Energy	$T_J = 25^{\circ}C$, $V_{CE} = 400$ V, $I_F = 30$ A, $di_F/dt = 1000$ A/ μ s			11	-	μJ
T _{rr}	Diode Reverse Recovery Time			-	29	-	ns

 $T_J = 175^{\circ}C$, $V_{CE} = 400$ V, $I_F = 15$ A, $di_F/dt = 1000$ A/ μs

 $T_J = 175^{\circ}C$, $V_{CE} = 400$ V, $I_F = 30$ A, $di_F/dt = 1000$ A/ μs

205

14

98

70

830

23

112

89

1031

23

_

nC

Α

μJ

ns

nC

Α

μJ

ns

nC

Α

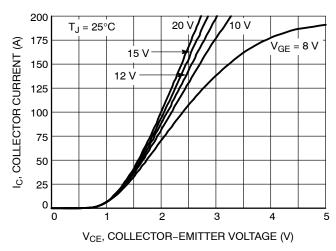
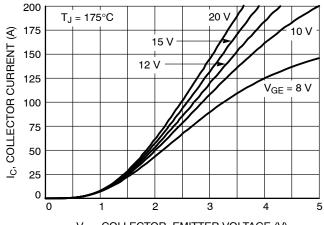


Figure 1. Typical Output Characteristics



V_{CE}, COLLECTOR-EMITTER VOLTAGE (V) Figure 2. Typical Output Characteristics

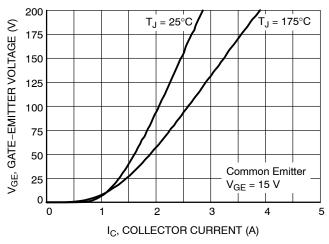


Figure 3. Typical Saturation Voltage Characteristics

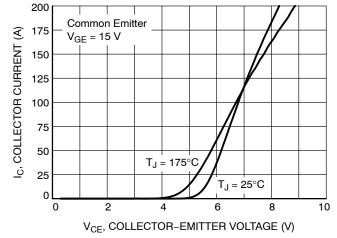


Figure 4. Typical Transfer Characteristics

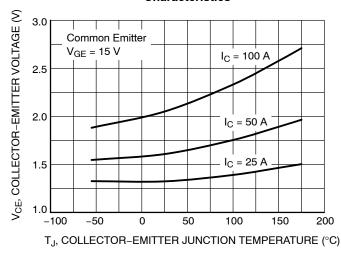
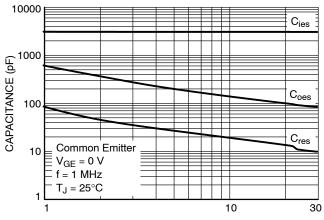


Figure 5. Saturation Voltage vs. Junction **Temperature**



V_{CE}, COLLECTOR-EMITTER VOLTAGE (V)

Figure 6. Capacitance Characteristics

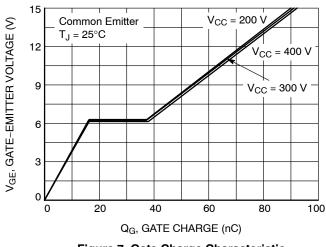


Figure 7. Gate Charge Characteristic

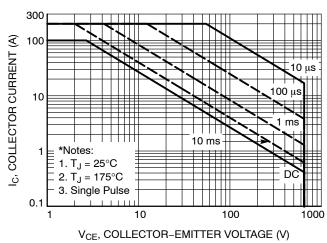


Figure 8. SOA Characteristics (FBSOA)

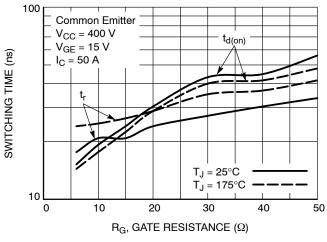


Figure 9. Turn-On Characteristics vs. Gate Resistance

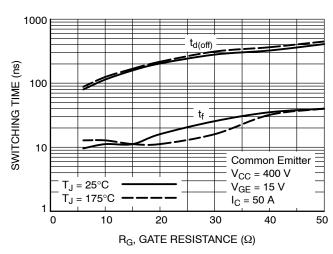


Figure 10. Turn-Off Characteristics vs. Gate Resistance

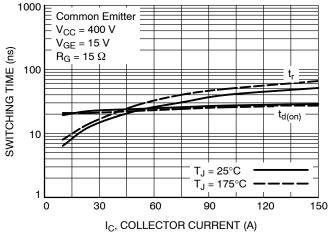


Figure 11. Turn-On Characteristics vs.
Collector Current

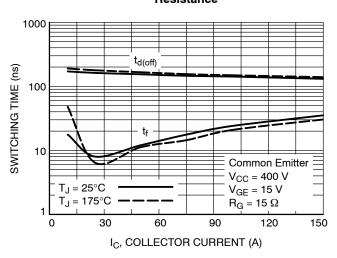


Figure 12. Turn-Off Characteristics vs.
Collector Current

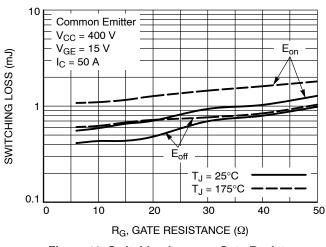


Figure 13. Switching Loss vs. Gate Resistance

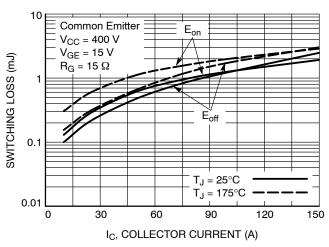


Figure 14. Switching Loss vs. Collector Current

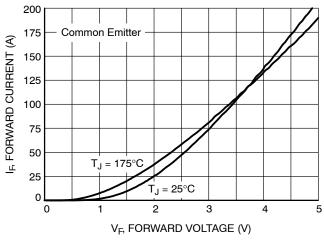
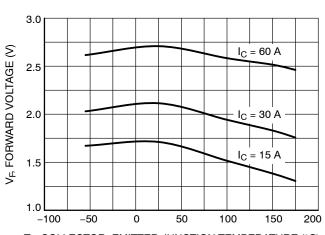


Figure 15. (Diode) Forward Characteristics



 $\label{eq:total_total} T_J, \mbox{ COLLECTOR-EMITTER JUNCTION TEMPERATURE (°C)} \\ \mbox{ Figure 16. (Diode) Forward Voltage vs.}$

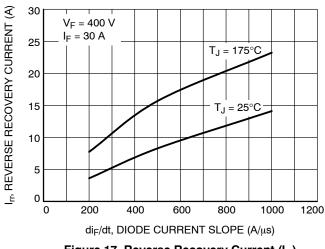


Figure 17. Reverse Recovery Current (I_{rr})

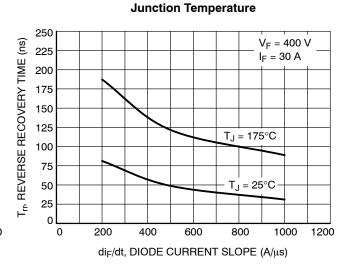


Figure 18. Reverse Recovery Time (T_{rr})

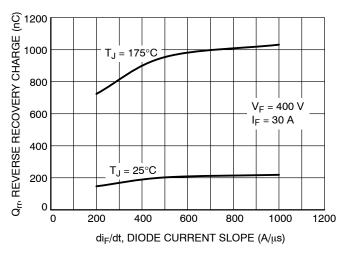


Figure 19. Stored Charge (Q_{rr})

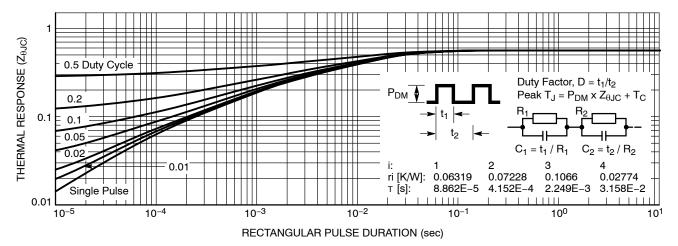


Figure 20. Transient Thermal Impedance of IGBT

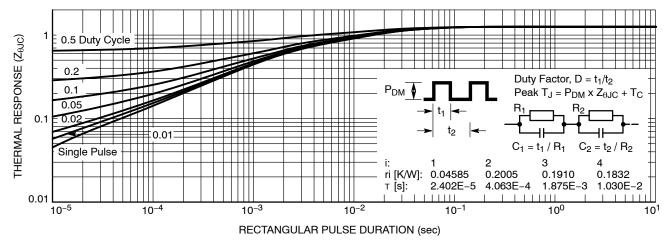
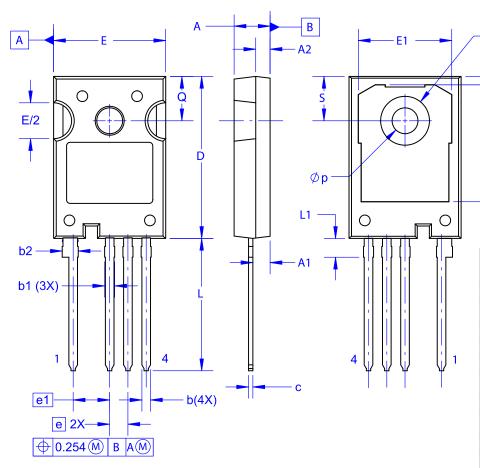


Figure 21. Transient Thermal Impedance of Diode

PACKAGE DIMENSIONS

TO-247-4LD CASE 340CJ ISSUE A



NOTES:

- A. NO INDUSTRY STANDARD APPLIES TO THIS PACKAGE.
 B. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD
 FLASH, AND TIE BAR EXTRUSIONS.
 C. ALL DIMENSIONS ARE IN MILLIMETERS.
 D. DRAWING CONFORMS TO ASME Y14.5-2009.

DIM	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	4.80	5.00	5.20		
A1	2.10	2.40	2.70		
A2	1.80	2.00	2.20		
b	1.07	1.20	1.33		
b1	1.20	1.40	1.60		
b2	2.02	2.22	2.42		
С	0.50	0.60	0.70		
D	22.34	22.54	22.74		
D1	16.00	16.25	16.50		
D2	0.97	1.17	1.37		
е	2	2.54 BS0)		
e1		5.08 BS0			
E	15.40	15.60	15.80		
E1	12.80	13.00	13.20		
E/2	4.80	5.00	5.20		
L	18.22	18.42	18.62		
L1	2.42	2.62	2.82		
р	3.40	3.60	3.80		
p1	6.60	6.80	7.00		
Q	5.97	6.17	6.37		
S	5.97	6.17	6.37		

Ø**p1**

D1

D2

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